



**HAL**  
open science

## **First investigations on stoichiometric lithium niobate as piezoelectric substrate for high-temperature surface acoustic waves applications**

Thierry Aubert, Ninel Kokanyan, Hassan Alhousseini, Amine Taguett, Florian Bartoli, Jérémy Streque, Hamid M'Jahed, Pascal Boulet, Omar Elmazria

### ► **To cite this version:**

Thierry Aubert, Ninel Kokanyan, Hassan Alhousseini, Amine Taguett, Florian Bartoli, et al.. First investigations on stoichiometric lithium niobate as piezoelectric substrate for high-temperature surface acoustic waves applications. IEEE Sensors 2017, IEEE, Oct 2017, Glasgow, United Kingdom. pp.576, 10.1109/icsens.2017.8234068 . hal-01628825

**HAL Id: hal-01628825**

**<https://hal.science/hal-01628825>**

Submitted on 11 Jan 2018

**HAL** is a multi-disciplinary open access archive for the deposit and dissemination of scientific research documents, whether they are published or not. The documents may come from teaching and research institutions in France or abroad, or from public or private research centers.

L'archive ouverte pluridisciplinaire **HAL**, est destinée au dépôt et à la diffusion de documents scientifiques de niveau recherche, publiés ou non, émanant des établissements d'enseignement et de recherche français ou étrangers, des laboratoires publics ou privés.

# First investigations on stoichiometric lithium niobate as piezoelectric substrate for high-temperature surface acoustic waves applications

Thierry Aubert, Ninel Kokanyan, Hassan Alhousseini,  
Amine Taguett, Florian Bartoli  
Laboratoire LMOPS EA 4423  
Université de Lorraine-CentraleSupélec  
57070 METZ, France  
[thierry.aubert@centralesupelec.fr](mailto:thierry.aubert@centralesupelec.fr)

Jérémy Streque, Hamid M'Jahed, Pascal Boulet, Omar  
Elmazria  
Institut Jean Lamour UMR 7198  
UMR 7198 Université de Lorraine-CNRS  
54506 Vandœuvre-lès-Nancy, France

**Abstract**—Surface acoustic waves (SAW) technology is very promising to achieve high-temperature wireless sensors. However, there is currently a need for piezoelectric substrates with a high electromechanical coupling coefficient ( $K^2 > 1\%$ ), able to operate under harsh environments, especially in the intermediate temperature range (300-600°C). None of the conventional SAW substrate can face this challenge. In particular congruent lithium niobate, whose  $K^2$  can exceed 5%, shows serious limitations from 300°C, mainly related to Li vacancies. Recent studies have demonstrated the potential of stoichiometric lithium niobate (s-LN) for high-temperature bulk acoustic waves applications. In this paper, we investigate this piezoelectric material for high-temperature SAW applications. In particular, we examine carefully the potential structural and chemical changes that s-LN surface can undergo during a high-temperature exposure. Finally, SAW resonators based on s-LN substrates are in situ characterized up to 600°C.

**Keywords**—high-temperature; stoichiometric lithium niobate; SAW;

## I. INTRODUCTION

Surface acoustic waves (SAW) technology has been being used for more than three decades for telecommunication applications. It is also of great interest for sensor applications owing to the potential large sensitivity of SAW devices to environmental conditions. Moreover, SAW sensors have a great added value as they are passive components. Consequently, they do need neither embedded electronics nor power source to be remotely interrogated. This property makes this technology particularly suitable to achieve wireless sensors able to operate in high-temperature environments (200-1000°C), provided the constitutive materials of the device are able to withstand these harsh conditions.

In this context, conventional SAW piezoelectric substrates have limitations that prevent their use above some typical temperatures. For instance, quartz shows a  $\alpha$ - $\beta$  phase transition at 573°C, but signal degradation occurs from 300°C, likely due to the increase in structural disorder with temperature [1]. In the same way, it is preferable not to operate lithium tantalate

and lithium niobate (LN) about half their Curie temperature, located at 610°C and 1140°C respectively [2]. Thus, congruent lithium niobate (c-LN) could be potentially used up to temperatures around 600°C, allowing SAW measurements in the intermediate temperature range (ITR), between 300 and 600°C. However, c-LN shows several limitations under high-temperature environments. First of all, as many oxides, LN is not stable under high-temperature poor-oxygen environments, undergoing strong O losses [3]. Moreover, owing to a significant concentration in Li vacancies, c-LN conductivity increases quickly with temperature [4]. Finally, the electrodes of SAW devices based on c-LN undergo important damages due to sparks related to LN pyroelectricity. Consequently, c-LN seems limited to applications up to 300°C [5].

Some other piezoelectric materials have been subsequently investigated in order to achieve high-temperature SAW devices. Langasite ( $\text{La}_3\text{Ga}_5\text{SiO}_{14}$ , LGS) crystals have been intensively studied and have given promising results, especially under air environment. Thus LGS crystals surface do not deteriorate up to 1000°C [6] and remains piezoelectric up to at least 1140°C [7]. LGS-based SAW devices have been operated for several months at 800°C [8]. Other notable performances have been obtained with AlN/Sapphire bilayer structure. AlN suffers from steady oxidation above 700°C in air [9], but can be operated up to at least 1000°C under low-O environments [10] or in air if protected by an overlayer [11].

However, LGS as well as AlN/Sapphire are limited by relatively weak electromechanical coupling coefficients  $K^2$ , which are not larger than 0.3%. In particular, such  $K^2$  values prevent the achievement of reflective delay lines. The latter device geometry is very convenient for sensor identification, allowing the design of ID tags. Such design requires very short pulses in time domain, and thus wide passband in frequency domain, meaning a  $K^2$  typically above 1%.

Thus, there is a need for a piezoelectric material with a high  $K^2$ , able to withstand high-temperature environments, in particular in the ITR. One promising candidate could be

stoichiometric lithium niobate (s-LN). This crystal presents much less defects of the lattice comparing to c-LN. The composition of a given LN crystal can be defined by the parameter  $X_c$  (where  $c_{Li}$  and  $c_{Nb}$  are the concentrations in Li and Nb atoms in the crystal respectively):

$$X_c = \frac{c_{Li}}{c_{Li} + c_{Nb}} \cdot 100$$

In s-LN crystals with ideal structure,  $X_c$  is equal to 50%, unlike to c-LN in which it is only of 48.3%. It has to be noted that the growth of s-LN crystals is connected with some difficulties with comparison to the growth of the c-LN [12]. Due to less Li vacancies, the s-LN conductivity is much lower than that of c-LN, and thus very promising measurements of BAW devices based on s-LN have been recently achieved up to 900°C [13]. In this paper, we investigate the stability of the surface of s-LN crystals exposed to high temperatures up to 700°C. Additionally, SAW devices based on s-LN crystals are electrically characterized up to 600°C by in situ measurements.

## II. EXPERIMENTAL

Near stoichiometric Z-oriented LN wafers (MTI Corp., Richmond, CA) were cut into 20 x 15 mm<sup>2</sup> rectangular plates. Three samples were annealed in an open-air furnace for 12h at 500°C, 600°C and 700°C respectively.

The chemical composition of the samples was obtained before and after annealing treatment by Raman spectroscopy measurements. Raman measurements were carried out with a Horiba Jobin Yvon ARAMIS spectrometer with a spectral resolution less than 1cm<sup>-1</sup>. The He-Ne laser with 632.8nm of wavelength was operated. The penetration depth was about 1µm. The spectra of Z(XY)Z configuration were measured in order to obtain E[TO] modes according to selection rules. The attention was focalized on E[TO<sub>1</sub>] Raman mode, corresponding to out of phase motion of Nb and O ions [14], which provides a possibility to calculate the composition of the crystal from the linewidth  $\Gamma$  of this mode [15]:

$$X_c = 51.28 - 0.232 * \Gamma$$

A fourth sample was structurally investigated by in situ X-ray diffraction (XRD) measurements performed with a D8 diffractometer (Bruker AXS, Karlsruhe, Germany) used in Bragg-Brentano geometry, equipped with a lynxeye PSD detector and using the CoK  $\alpha$  radiation ( $\lambda = 0.179026$  nm). These measurements were conducted between the ambient and 700°C. Namely, the sample was rapidly heated from the ambient to 400°C and then maintained at this temperature for 12h. During this plateau, four XRD diagrams were obtained every 3h. The same procedure was repeated at 500, 600 and 700°C. Finally, three last XRD diagrams were measured during the cooling phase at 600, 500 and 400°C respectively.

150-nm thick aluminum thin films were deposited on some others samples by sputtering method. SAW resonators with a wavelength of 6.5 µm were then achieved by conventional photolithography and wet etching. The SAW propagation path was along Y direction. These devices were in situ electrically characterized up to 600°C using a network analyzer and an RF prober station (s-1160, Signatone Corp., Gilroy, CA) equipped

with an S-1060 series Signatone thermal probing system. In order to allow a calibrated characterization of the devices, an adapted RF probes (Z Probe SussMicrotech) with cooling system was used.

## III. RESULTS AND DISCUSSIONS

### A. Raman measurements

The Raman measurements performed before annealing treatments show that the samples under consideration have a composition close to the stoichiometric one with the parameter  $X_c$  being about 49.85%. No noticeable changes of E[TO<sub>1</sub>] mode were observed for the same samples after the annealing processes at temperatures from 500 to 700°C (Fig. 1).

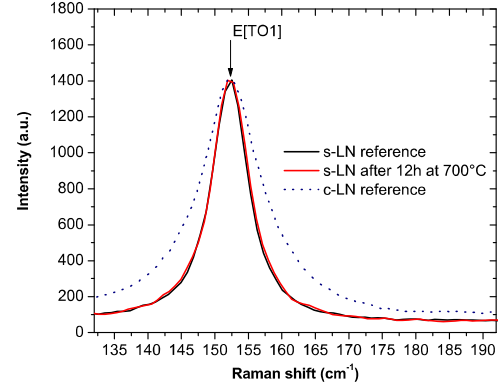


Fig. 1. E[TO<sub>1</sub>] mode of s-LN wafers before and after a 12h-long annealing process at 700°C. E[TO<sub>1</sub>] mode of c-LN sample was added for comparison.

This result evidences that the chemical composition of the surface of the investigated s-LN crystals is not altered by the annealing treatments, the parameter  $X_c$  staying in the range between 49.8 and 49.9%.

### B. In situ XRD measurements

The XRD diagram of the non-annealed samples contains only peaks corresponding to the (00l) reticular plans. No new phase appears during the 48h-long annealing process between 400 and 700°C. This intensity of the main peak, corresponding to the (006) reflex, decreases with the temperature, in particular at 700°C (Fig. 2). However, this intensity remains constant during each 12h-long plateau, at 400, 500, 600 and 700°C respectively (Fig. 3).

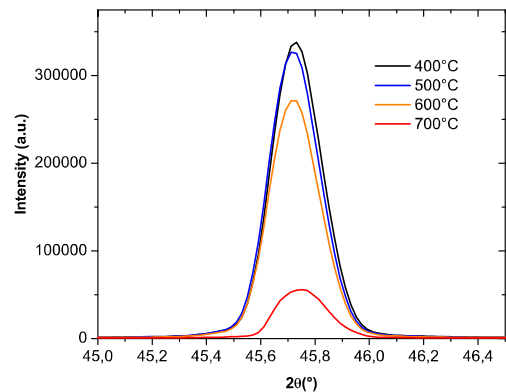


Fig. 2. s-LN (006) reflex measured at different temperatures

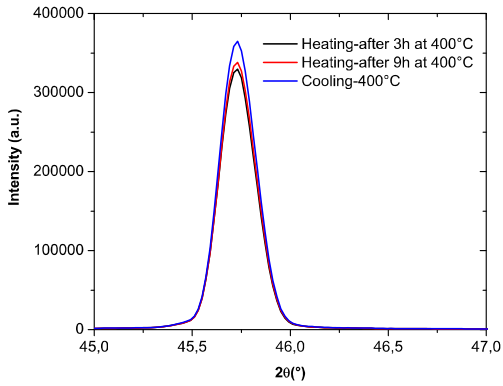


Fig. 3. s-LN (006) reflex measured at 400°C at different times

Moreover, the intensity measured during the cooling phase for each temperature of measurements is the same as during the heating phase plateaus (Fig. 3). Consequently, we can assume that the decrease of the XRD intensity with temperature is related to the Debye-Waller effect and not to a degradation of the crystal.

### C. In situ SAW measurements

The devices were first electrically characterized by step of 25°C between the ambient and 600°C. Then, they were steadily cooled back to room temperature and measured every 50°C. During the heating phase, the quality factor degrades in the temperature range between 250 and 450°C, and then improves back suddenly at 500°C (not shown here). The behavior is completely different during the cooling phase (Fig. 4). This time, the signal quality remains quite good in the temperature range between 500 and 300°C, and then degrades significantly, except around 50°C. These phenomena are not currently understood, and more investigations are required.

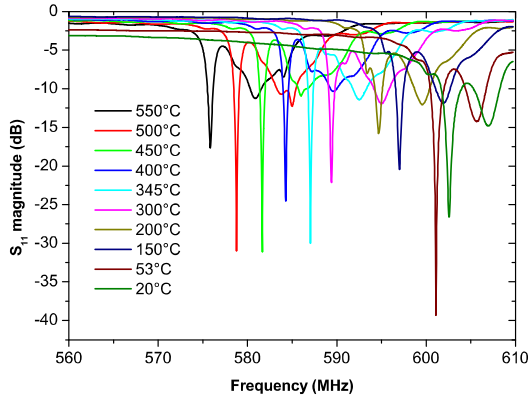


Fig. 4.  $S_{11}$  magnitude of s-LN-based SAW resonator characterized at different temperatures

## IV. CONCLUSION AND PERSPECTIVES

In situ XRD and Raman spectroscopy measurements show that the microstructure and the chemical composition of s-LN substrates are not altered by an exposure of several hours at high temperatures up to 700°C. High-temperature characterization of s-LN-based SAW resonators have been achieved up to 600°C. Results are quite different between the

heating and the cooling phase, possibly indicating the need for a pre-aging process. Additional experiments are ongoing to clarify this point.

## ACKNOWLEDGMENT

This work was financially supported by the Lorraine Regional Council and the French PIA project “Lorraine Université d’Excellence”, reference ANR-15-IDEX-04-LUE. Experiments were carried out on equipments part of IJL-TUBE Davm funded by FEDER (EU), PIA, region Grand Est, Metropole Grand Nancy and ICEEL.

## References

- [1] J. Haines, O. Cambon, D.A. Keen, M.G. Tucker, M.T. Dove, “Structural disorder and loss of piezoelectric properties in  $\alpha$ -quartz at high temperature,” *Appl. Phys. Lett.*, 81, no. 16, pp. 2968-2970, 2002.
- [2] R. Turner, P. Fuierer, R. Newnham, T. Shrout, “Materials for high temperature acoustic and vibration sensors: a review,” *Applied Acoustics*, 41, no. 4, pp. 299–324, 1994.
- [3] M. Budimir, A. Mohimi, C. Selcuk, T. Gan, “High temperature NDE Transducers for Condition Monitoring of Superheated Steam Pipes in Nuclear Power Plants,” in *Proc. International Conf. Nucl. Energy for New Europe*, pp. 502.1-502.8, 2011.
- [4] Y. Li, Y. Zheng, X. Tu, K. Xiong, Q. Lin, E. Shi, “High temperature resistivity of lithium niobate and related crystals,” in *Proc IEEE SPAWDA*, pp. 283-286, 2014.
- [5] R. Hauser, L. Reindl, J. Biniash, “High temperature stability of LiNbO<sub>3</sub> based SAW devices,” in *Proc IEEE Ultrasonics Symp.*, pp.192-195, 2003.
- [6] T. Aubert and O. Elmazria, “Stability of langasite regarding SAW applications above 800°C in air atmosphere,” in *Proc. IEEE Ultrasonics Symp.*, pp. 2098–2101, 2012.
- [7] T. Aubert, J. Bardong, O. Elmazria, G. Bruckner, B. Assouar, “Iridium interdigital transducers for high-temperature surface acoustic wave applications,” *IEEE Trans. Ultrason. Ferroelectr. Freq. Control*, 59, no. 2, pp. 194-197, 2012.
- [8] M. Pereira da Cunha, R. J. Lad, T. Moonlight, G. Bernhardt, D.J. Frankel, “High temperature stability of langasite surface acoustic wave devices,” in *Proc. IEEE Ultrasonics Symp.*, pp. 205-208, 2008.
- [9] T. Aubert, O. Elmazria, B. Assouar, E. Blampain, A. Hamdan, D. Genève, S. Weber, “Investigations on AlN/sapphire piezoelectric bilayer structure for high-temperature SAW applications,” *IEEE Trans. Ultrason. Ferroelectr. Freq. Control*, 59, no. 5, pp. 999-1005, 2012.
- [10] T. Aubert, J. Bardong, O. Legrani, O. Elmazria, B. Assouar, G. Bruckner, A. Talbi, “In situ high-temperature characterization of AlN-based surface acoustic wave devices,” *J. Appl. Phys.*, 114, art. no. 014505, 2013.
- [11] O. Legrani, T. Aubert, O. Elmazria, A. Bartaszyte, P. Nicolay, A. Talbi, P. Boulet, J. Ghanbaja, D. Mangin, “AlN/IDT/AlN/Sapphire SAW heterostructure for high-temperature applications,” *IEEE Trans. Ultrason. Ferroelectr. Freq. Control*, 63, pp. 898-906, 2016.
- [12] T. Volk and M. Wohlecke, “Lithium Niobate: Defects, Photorefracion, and Ferroelectric Switching,” Springer, Berlin, 264, 2008.
- [13] A. Weidenfelder, J. Shi, P. Fielitz, G. Borchardt, K.D. Becker, H. Fritze, “Electrical and electromechanical properties of stoichiometric lithium niobate at high-temperatures,” *Solid State Ionics*, 225, pp. 26-29, 2012.
- [14] A.V. Postnikov, V. Caviuc, G. Borstel, “Structure optimization and frozen phonons in LiNbO<sub>3</sub>,” *J. Phys. Chem. Solids*, 61, pp. 295, 2000.
- [15] Y. Zhang, L. Guilbert, P. Bourson, K. Polgar, M. D. Fontana, “Characterisation of short-range heterogeneities in sub-congruent lithium niobate by micro-Raman spectroscopy,” *J. Phys.: Condens. Matter*, 18, pp. 957–963, 2006.